

**Search Notes**

Application/Control No.

10/656,330

Examiner

David Mis

Applicant(s)/Patent under  
Reexamination

KIM ET AL.

Art Unit

2817

**SEARCHED**

Class	Subclass	Date	Examiner
332	103-106,	2/23/2005	DM
	108,		
	112-114		
375	239,		
	279-284,		
	295, 308,		
	316,		
	329-333		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
as	above	2/23/2005	DM

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR